



N-Channel 25 V (D-S) MOSFET



PRODUCT SUMMARY						
V _{DS} (V)	25					
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.0086					
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.0095					
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 2.5 \text{ V}$	0.0115					
Q _g typ. (nC)	17.5					
I _D (A) ^a	18					
Configuration	Single					

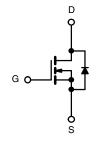
FEATURES

- TrenchFET® power MOSFET
- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



APPLICATIONS

- Synchronous buck
 - Low side



N-Channel MOSFET

ORDERING INFORMATION				
Package	SO-8			
Lead (Pb)-free	Si4116DY-T1-E3			
Lead (Pb)-free and halogen-free	Si4116DY-T1-GE3			

ABSOLUTE MAXIMUM RATING	3S (T _A = 25 °C, ι	ınless otherv	wise noted)	
PARAMETER		SYMBOL	LIMIT	UNIT
Drain-source voltage		V _{DS}	25	V
Gate-source voltage		V_{GS}	± 12	v
	T _C = 25 °C		18	
O-ation	T _C = 70 °C	1 .	14.3	
Continuous drain current (T _J = 150 °C)	T _A = 25 °C	I _D	12.7 ^{b, c}	
	T _A = 70 °C		10.1 ^{b, c}	
Pulsed drain current		I _{DM}	50	A
Octobra a service destruite de la consti	T _C = 25 °C		4.5	
Continuous source-drain diode current	T _A = 25 °C	- I _S	2.2 b, c	
Single pulse avalanche current		I _{AS}	20	
Avalanche energy	L = 0.1 mH	E _{AS}	20	mJ
Maximum power dissipation	T _C = 25 °C		5	
	T _C = 70 °C		3.2	14/
	T _A = 25 °C	P _D	2.5 ^{b, c}	W
	T _A = 70 °C	1	1.6 ^{b, c}	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C

THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient b, d	t ≤ 10 s	R _{thJA}	43	50	°C/W	
Maximum junction-to-foot (drain)	Steady state	R_{thJF}	19	25	7 C/W	

Notes

- a. Based on T_C = 25 °C
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s
- d. Maximum under steady state conditions is 95 °C/W

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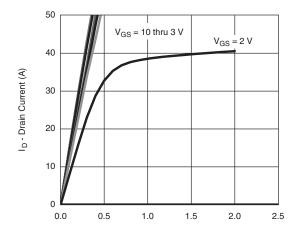
SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I - 250 uA	-	30	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-4	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.6	-	1.4	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	-	± 100	nA	
Zara gata valtaga drain avurant		V _{DS} = 25 V, V _{GS} = 0 V	-	-	1	uA	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 25 V, V _{GS} = 0 V, T _J = 55 °C	-	-	10		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30	-	-	Α	
		V _{GS} = 10 V, I _D = 10 A	-	0.0071	0.0086	Ω	
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 7 A	-	0.0078	0.0095		
		$V_{GS} = 2.5 \text{ V}, I_D = 5 \text{ A}$	-	0.0090	0.0115		
Forward transconductance a	9 _{fs}	V _{DS} = 15 V, I _D = 10 A	-	68	-	S	
Dynamic ^b							
Input capacitance	C _{iss}		-	1925	-	pF	
Output capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	305	-		
Reverse transfer capacitance	C _{rss}		-	135	-		
		V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A	-	37	56	nC	
Total gate charge	Qg	, , , , , , , , , , , , , , , , , , , 	-	17.5	27		
Gate-source charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$	-	3.7	-		
Gate-drain charge	Q _{gd}		-	3.3	-		
Gate resistance	R_g	f = 1 MHz	-	1.6	3	Ω	
Turn-on delay time	t _{d(on)}		-	13	25		
Rise time	t _r	$V_{DD} = 15 \text{ V}, R_1 = 1.5 \Omega$	-	11	20		
Turn-off delay time	t _{d(off)}	$I_D \cong 10$ A, $V_{GEN} = 4.5$ V, $R_g = 1$ Ω	-	50	90		
Fall time	t _f		-	15	30		
Turn-on delay time	t _{d(on)}		-	7	14	ns	
Rise time	t _r	V_{DD} = 15 V, R_L = 1.5 Ω	-	10	20	İ	
Turn-off delay time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	31	55		
Fall time	t _f		-	9	18		
Drain-Source Body Diode Characterist	ics		1				
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	4.5		
Pulse diode forward current ^a	I _{SM}		-	-	50	Α	
Body diode voltage	V _{SD}	I _S = 3 A	-	0.69	1.1	V	
Body diode reverse recovery time	t _{rr}	-	-	26	45	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = 5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	16	30	nC	
Reverse recovery fall time	t _a	Т _J = 25 °C	-	13	-		
Reverse recovery rise time	t _b		_	13	-	ns	

Notes

- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing

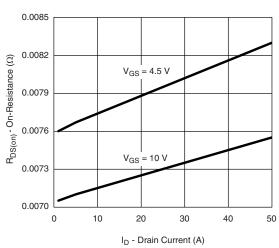
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



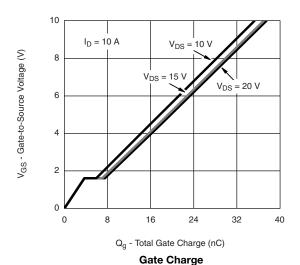


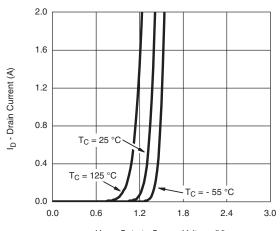
 $V_{\mbox{\scriptsize DS}}$ - Drain-to-Source Voltage (V)

Output Characteristics



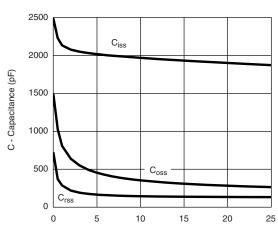
On-Resistance vs. Drain Current and Gate Voltage





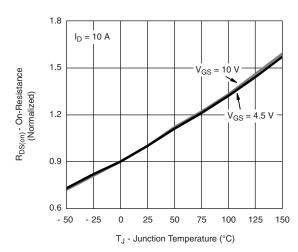
 V_{GS} - Gate-to-Source Voltage (V)

Transfer Characteristics



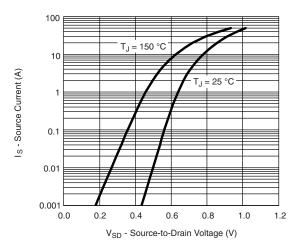
V_{DS} - Drain-to-Source Voltage (V)

Capacitance

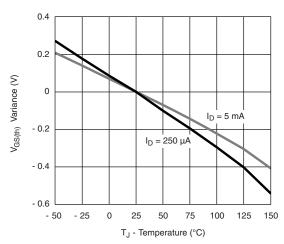


On-Resistance vs. Junction Temperature

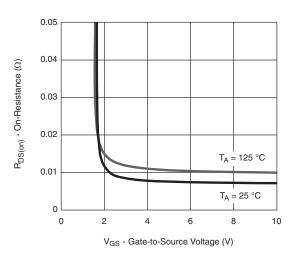




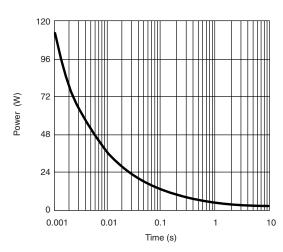
Source-Drain Diode Forward Voltage



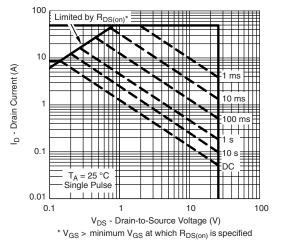
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

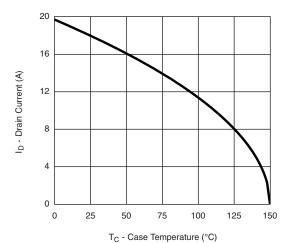


Single Pulse Power, Junction-to-Ambient

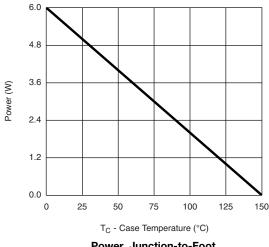


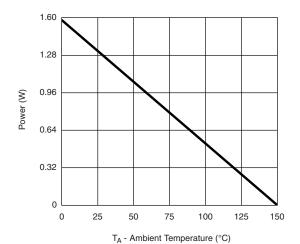
Safe Operating Area, Junction-to-Ambient





Current Derating a



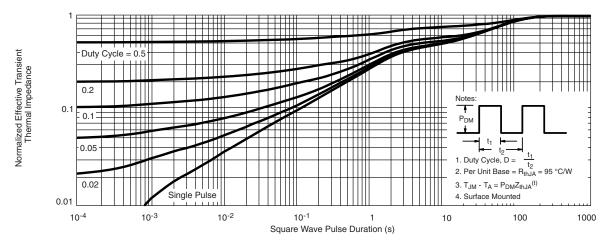


Power, Junction-to-Foot

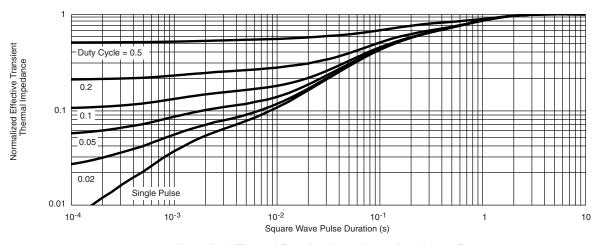
Power, Junction-to-Ambient

a. The power dissipation P_D is based on T_J max = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



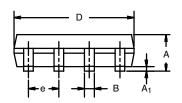
Normalized Thermal Transient Impedance, Junction-to-Foot

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SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INC	HES	
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
Е	3.80	4.00	0.150	0.157	
е	1.27	BSC	0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
FCN: C-06527-Bey 11-Sen-06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498

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RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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